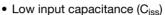


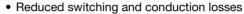
N-Channel 650 V (D-S) Super Junction Power MOSFET

PRODUCT SUMMARY				
V _{DS} (V) at T _J max. 650				
R _{DS(on)} at 25 °C (Ω)	V _{GS} = 10 V 0.46			

FEATURES







- Ultra low gate charge (Qq)
- Avalanche energy rated (UIS)

APPLICATIONS

- Server and telecom power supplies
- Switch mode power supplies (SMPS)
- Power factor correction power supplies (PFC)
- Lighting
 - High-intensity discharge (HID)
 - Fluorescent ballast lighting



ABSOLUTE MAXIMUM RATINGS (T _C = 25 °C, unless otherwise noted)						
PARAMETER	SYMBOL	LIMIT	UNIT			
Drain-Source Voltage	V_{DS}	650	V			
Gate-Source Voltage	V_{GS}	± 30	V			
Continuous Drain Current (T, = 150 °C)	V_{GS} at 10 V $T_{C} = 25 ^{\circ}\text{C}$ $T_{C} = 100 ^{\circ}\text{C}$	25 °C I _D	8			
Continuous Diain Current (1) = 130 O)	$T_C = 100 ^{\circ}C$		5	Α		
Pulsed Drain Current ^a	I _{DM}	24				
Linear Derating Factor		1.67	W/°C			
Single Pulse Avalanche Energy b		E _{AS}	700	mJ		
Maximum Power Dissipation	P_{D}	90	W			
Operating Junction and Storage Temperature Range	T _J , T _{stg}	-55 to +150	°C			
Drain-Source Voltage Slope T _J = 125 °C		dV/dt	50	V/ns		
Reverse Diode dV/dt ^d	15					
Soldering Recommendations (Peak Temperature) c		260	°C			

- a. Repetitive rating; pulse width limited by maximum junction temperature. b. $V_{DD}=100$ V, starting T_J = 25 °C, L = 30mH, R_g = 25 Ω , I_{AS} =13A.
- c. 1.6 mm from case.
- d. $I_{SD} \le I_D$, dI/dt = 100 A/ μ s, starting $T_J = 25$ °C.



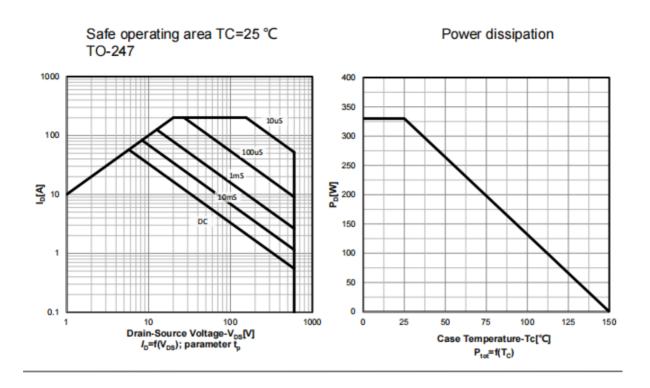
THERMAL RESISTANCE RATINGS					
PARAMETER SYMBOL TYP. MAX. UNIT					
Maximum Junction-to-Ambient	R _{thJA}	-	62	°C/W	
Maximum Junction-to-Case (Drain)	R _{thJC}	=	0.38	C/VV	

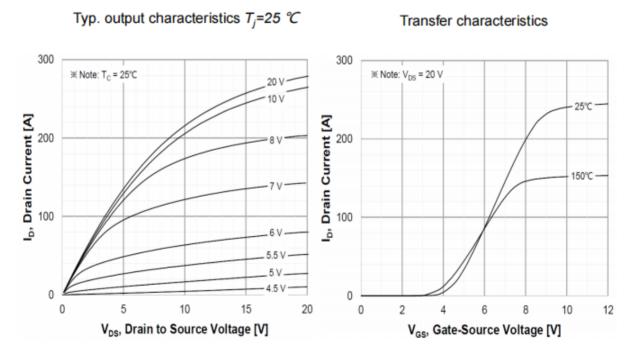
PARAMETER	SYMBOL	TEST CONDITIONS		MIN.	TYP.	MAX.	UNIT
Static					•	•	
Drain-Source Breakdown Voltage	V _{DS}	V _{GS} :	= 0 V, I _D = 1 mA	650	-	-	V
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$	Reference	e to 25 °C, I _D = 1 mA	-	0.70	-	V/°C
Gate-Source Threshold Voltage (N)	V _{GS(th)}	V _{DS} =	= V _{GS} , I _D = 250 μA	2.5	-	4.5	V
		V _{GS} = ± 20 V		-	-	± 100	nA
Gate-Source Leakage	I_{GSS}		V _{GS} = ± 30 V	-	-	± 1	μΑ
			= 650V, V _{GS} = 0 V	-	-	1	
Zero Gate Voltage Drain Current	I_{DSS}		/, V _{GS} = 0 V, T _J = 125 °C	-	_	100	μA
Drain-Source On-State Resistance	R _{DS(on)}	V _{GS} = 10 V	I _D =2A	-	0.460	-	Ω
Forward Transconductance	9 _{fs}	V _{DS}	s = 30 V, I _D = 2A	-	5.6	-	S
Dynamic							
Input Capacitance	C _{iss}		V _{GS} = 0 V,	-	1100	-	
Output Capacitance	C _{oss}	7	$V_{DS} = 100 \text{ V},$	-	330	-	
Reverse Transfer Capacitance	C _{rss}	f = 1 MHz		-	4	-	pF
Effective Output Capacitance, Energy Related ^a	C _{o(er)}	V _{DS} = 0 V to 520 V, V _{GS} = 0 V		-	63	-	
Effective Output Capacitance, Time Related ^b	C _{o(tr)}			-	213	-	
Total Gate Charge	Qg				38	-	
Gate-Source Charge	Q _{gs}	V _{GS} = 10 V		-	39	-	nC
Gate-Drain Charge	Q _{gd}	1	†		47	-	
Turn-On Delay Time	t _{d(on)}	V _{DD} = 520 V, I _D = 20A,		-	18	25	
Rise Time	t _r			ı	24	55	ns
Turn-Off Delay Time	t _{d(off)}				80	-	115
Fall Time	t _f	$V_{GS} = 10 \text{ V}, R_g = 9.1 \Omega$		-	12	-	
Gate Input Resistance	R_g	f = 1 MHz, open drain		1	0.8	-	Ω
Drain-Source Body Diode Characteristic	s						
Continuous Source-Drain Diode Current	Is	MOSFET symbol showing the integral reverse p - n junction diode		-	-	8	^
Pulsed Diode Forward Current	I _{SM}			1	-	24	- A
Diode Forward Voltage	V _{SD}	T _J = 25 °C, I _S = 8 A, V _{GS} = 0 V		-	-	1.5	V
Reverse Recovery Time	t _{rr}	T _J = 25 °C, I _F = I _S = 8 A, dl/dt = 100 A/μs, V _R = 400 V		-	80	-	ns
Reverse Recovery Charge	Q _{rr}			-	5.8	-	μC
Reverse Recovery Current	I _{RRM}			_	45	_	Α

Notes

- a. $C_{oss(er)}$ is a fixed capacitance that gives the same energy as C_{oss} while V_{DS} is rising from 0 % to 80 % V_{DSS} . b. $C_{oss(tr)}$ is a fixed capacitance that gives the same charging time as C_{oss} while V_{DS} is rising from 0 % to 80 % V_{DSS} .





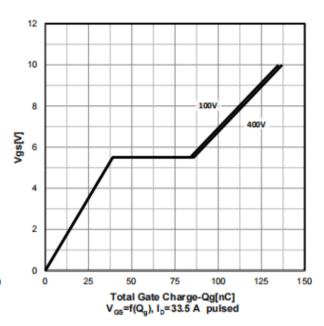




Typ. drain-source on-state resistance

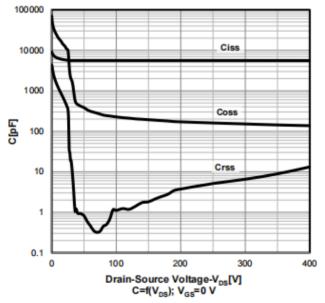
80
70
60
60
40
30
20
0 15 30 45 60 75 90
Drain-Source Current-I_D[A]
R_{DS}(on)=f(I_D); parameter:V_{GS}

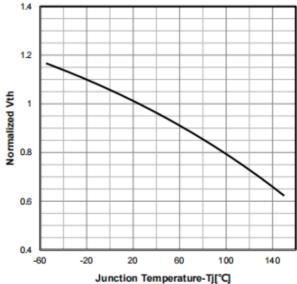
Typ. gate charge characteristics



Typ. capacitances

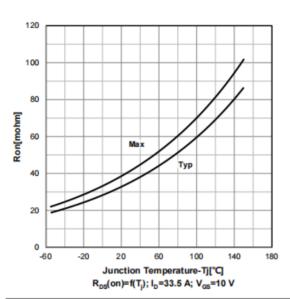




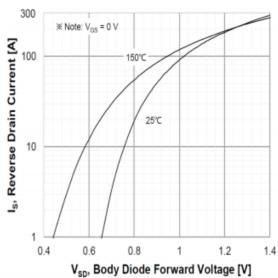




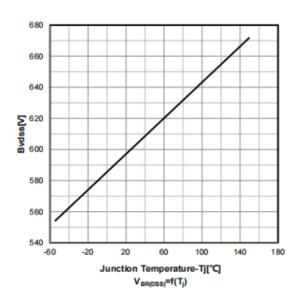
On-resistance vs temperature



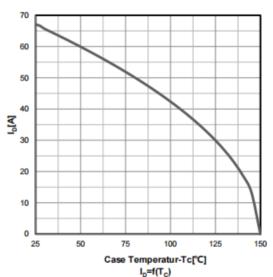
Forward characteristics of reverse diode



Drain-source breakdown voltage



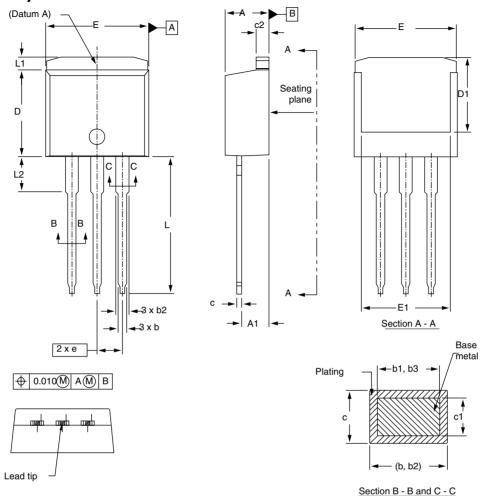
Drain current vs temperature



服务热线:400-655-8788 5



I²PAK (TO-262)



	MILLIMETERS		INC	HES
DIM.	MIN.	MAX.	MIN.	MAX.
Α	4.06	4.83	0.160	0.190
A1	2.03	3.02	0.080	0.119
b	0.51	0.99	0.020	0.039
b1	0.51	0.89	0.020	0.035
b2	1.14	1.78	0.045	0.070
b3	1.14	1.73	0.045	0.068
С	0.38	0.74	0.015	0.029
c1	0.38	0.58	0.015	0.023
c2	1.14	1.65	0.045	0.065

	MILLIMETERS		INC	HES
DIM.	MIN.	MAX.	MIN.	MAX.
D	8.38	9.65	0.330	0.380
D1	6.86	-	0.270	-
E	9.65	10.67	0.380	0.420
E1	6.22	-	0.245	-
е	2.54 l	2.54 BSC		BSC
L	13.46	14.10	0.530	0.555
L1	-	1.65	-	0.065
L2	3.56	3.71	0.140	0.146

Scale: None

Notes

- 1. Dimensioning and tolerancing per ASME Y14.5M-1994.
- 2. Dimension D and E do not include mold flash. Mold flash shall not exceed 0.127 mm per side. These dimensions are measured at the outmost extremes of the plastic body.
- 3. Thermal pad contour optional within dimension E, L1, D1, and E1.4
- . Dimension b1 and c1 apply to base metal only.



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